1 MHz to $10 \mathrm{GHz}, 55 \mathrm{~dB}$ Log Detector/Controller

## Data Sheet

## FEATURES

## Wide bandwidth: $1 \mathbf{~ M H z}$ to $10 \mathbf{~ G H z}$

High accuracy: $\pm 1.0 \mathrm{~dB}$ over temperature
55 dB dynamic range up to $8 \mathrm{GHz} \pm 3 \mathrm{~dB}$ error
Stability over temperature: $\pm 0.5 \mathrm{~dB}$
Low noise measurement/controller output, VOUT
Pulse response time: $6 \mathrm{~ns} / 10 \mathrm{~ns}$ (fall/rise)
Small footprint, $2 \mathrm{~mm} \times 3 \mathrm{~mm}$ LFCSP
Supply operation: 3.0 V to 5.5 V at 22 mA
Fabricated using high speed SiGe process

## APPLICATIONS

RF transmitter PA setpoint control and level monitoring Power monitoring in radio link transmitters

## RSSI measurement in base stations, WLANs, WiMAX, and radars

## GENERAL DESCRIPTION

The AD8317 is a demodulating logarithmic amplifier, capable of accurately converting an RF input signal to a corresponding decibel-scaled output. It employs the progressive compression technique over a cascaded amplifier chain, each stage of which is equipped with a detector cell. The device can be used in either measurement or controller modes. The AD8317 maintains accurate $\log$ conformance for signals of 1 MHz to 8 GHz and provides useful operation to 10 GHz . The input dynamic range is typically 55 dB (referenced to $50 \Omega$ ) with less than $\pm 3 \mathrm{~dB}$ error. The AD8317 has $6 \mathrm{~ns} / 10 \mathrm{~ns}$ response time (fall time/rise time) that enables RF burst detection to a pulse rate of beyond 50 MHz . The device provides unprecedented logarithmic intercept stability vs. ambient temperature conditions. A supply of 3.0 V to 5.5 V is required to power the device. Current consumption is typically 22 mA , and it decreases to $200 \mu \mathrm{~A}$ when the device is disabled.

The AD8317 can be configured to provide a control voltage to a power amplifier or a measurement output from the VOUT pin. Because the output can be used for controller applications, special attention has been paid to minimize wideband noise. In this mode, the setpoint control voltage is applied to the VSET pin.

FUNCTIONAL BLOCK DIAGRAM


Figure 1.

The feedback loop through an RF amplifier is closed via VOUT, the output of which regulates the output of the amplifier to a magnitude corresponding to $\mathrm{V}_{\text {SET. }}$. The AD8317 provides 0 V to ( $\mathrm{V}_{\text {pos }}-0.1 \mathrm{~V}$ ) output capability at the VOUT pin, suitable for controller applications. As a measurement device, VOUT is externally connected to VSET to produce an output voltage, Vout, that is a decreasing linear-in- dB function of the RF input signal amplitude.
The logarithmic slope is $-22 \mathrm{mV} / \mathrm{dB}$, determined by the VSET interface. The intercept is 15 dBm (referenced to $50 \Omega, \mathrm{CW}$ input) using the INHI input. These parameters are very stable against supply and temperature variations.

The AD8317 is fabricated on a SiGe bipolar IC process and is available in a $2 \mathrm{~mm} \times 3 \mathrm{~mm}$, 8-lead LFCSP with an operating temperature range of $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$.

Rev. D
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## SPECIFICATIONS

$V_{\text {POS }}=3 \mathrm{~V}, \mathrm{C}_{\text {LPF }}=1000 \mathrm{pF}, \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, 52.3 \Omega$ termination resistor at INHI, unless otherwise noted.
Table 1.

| Parameter | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| SIGNAL INPUT INTERFACE Specified Frequency Range DC Common-Mode Voltage | INHI (Pin 1) | 0.001 | $V_{\text {POS }}-0.6$ | 10 | $\begin{aligned} & \mathrm{GHz} \\ & \mathrm{~V} \end{aligned}$ |
| MEASUREMENT MODE | VOUT (Pin 5) shorted to VSET (Pin 4), sinusoidal input signal |  |  |  |  |
| $\mathrm{f}=900 \mathrm{MHz}$ | $\mathrm{R}_{\text {TAD }}=18 \mathrm{k} \Omega$ |  |  |  |  |
| Input Impedance |  | 1500\||0.33 |  |  | $\Omega \\| \mathrm{pF}$ |
| $\pm 1 \mathrm{~dB}$ Dynamic Range | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | 50 |  |  | dB |
|  | $-40^{\circ} \mathrm{C}<\mathrm{T}_{\mathrm{A}}<+85^{\circ} \mathrm{C}$ | 46 |  |  | dB |
| Maximum Input Level | $\pm 1 \mathrm{~dB}$ error | -3 |  |  | dBm |
| Minimum Input Level | $\pm 1 \mathrm{~dB}$ error | -53 |  |  | dBm |
| Slope ${ }^{1}$ |  | -25 | -22 | -19.5 | $\mathrm{mV} / \mathrm{dB}$ |
| Intercept ${ }^{1}$ |  | 12 | 15 | 21 | dBm |
| Output Voltage, High Power In | $\mathrm{P}_{\text {IN }}=-10 \mathrm{dBm}$ | 0.42 | 0.58 | 0.78 | V |
| Output Voltage, Low Power In | $\mathrm{PIN}_{\text {IN }}=-40 \mathrm{dBm}$ | 1.00 | 1.27 | 1.40 | V |
| $\mathrm{f}=1.9 \mathrm{GHz}$ | $\mathrm{R}_{\text {TADJ }}=8 \mathrm{k} \Omega$ |  |  |  |  |
| Input Impedance |  | 950\||0.38 |  |  | $\Omega \\| \mathrm{pF}$ |
| $\pm 1 \mathrm{~dB}$ Dynamic Range | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | 50 |  |  | dB |
|  | $-40^{\circ} \mathrm{C}<\mathrm{T}_{\mathrm{A}}<+85^{\circ} \mathrm{C}$ | 48 |  |  | dB |
| Maximum Input Level | $\pm 1 \mathrm{~dB}$ error | -4.00 |  |  | dBm |
| Minimum Input Level | $\pm 1 \mathrm{~dB}$ error | -54 |  |  | dBm |
| Slope ${ }^{1}$ |  | -25 | -22 | -19.5 | $\mathrm{mV} / \mathrm{dB}$ |
| Intercept ${ }^{1}$ |  | 10 | 14 | 20 | dBm |
| Output Voltage, High Power In | $\mathrm{P}_{\text {IN }}=-10 \mathrm{dBm}$ | 0.35 | 0.54 | 0.80 | V |
| Output Voltage, Low Power In | $\mathrm{PIN}_{\text {IN }}=-35 \mathrm{dBm}$ | 0.75 | 1.21 | 1.35 | V |
| $\mathrm{f}=2.2 \mathrm{GHz}$ | $\mathrm{R}_{\text {TAD }}=8 \mathrm{k} \Omega$ |  |  |  |  |
| Input Impedance |  | 810\||0.39 |  |  | $\Omega \\| \mathrm{pF}$ |
| $\pm 1 \mathrm{~dB}$ Dynamic Range | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | 50 |  |  | dB |
|  | $-40^{\circ} \mathrm{C}<\mathrm{T}_{\mathrm{A}}<+85^{\circ} \mathrm{C}$ | 47 |  |  | dB |
| Maximum Input Level | $\pm 1 \mathrm{~dB}$ error | -5 |  |  | dBm |
| Minimum Input Level | $\pm 1 \mathrm{~dB}$ error | -55 |  |  | dBm |
| Slope ${ }^{1}$ |  | -22 |  |  | $\mathrm{mV} / \mathrm{dB}$ |
| Intercept ${ }^{1}$ |  | 14 |  |  | dBm |
| Output Voltage, High Power In | $\mathrm{P}_{\text {IN }}=-10 \mathrm{dBm}$ | 0.53 |  |  | V |
| Output Voltage, Low Power In | $\mathrm{P}_{\text {IN }}=-40 \mathrm{dBm}$ | 1.20 |  |  | V |
| $\mathrm{f}=3.6 \mathrm{GHz}$ | $\mathrm{R}_{\text {TADJ }}=8 \mathrm{k} \Omega$ |  |  |  |  |
| Input Impedance |  | 300\||0.33 |  |  | $\Omega \\| \mathrm{pF}$ |
| $\pm 1 \mathrm{~dB}$ Dynamic Range | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | 42 |  |  | dB |
|  | $-40^{\circ} \mathrm{C}<\mathrm{T}_{\mathrm{A}}<+85^{\circ} \mathrm{C}$ | 40 |  |  | dB |
| Maximum Input Level | $\pm 1 \mathrm{~dB}$ error | -6 |  |  | dBm |
| Minimum Input Level | $\pm 1 \mathrm{~dB}$ error | -48 |  |  | dBm |
| Slope ${ }^{1}$ |  | -22 |  |  | $\mathrm{mV} / \mathrm{dB}$ |
| Intercept ${ }^{1}$ |  | 11 |  |  | dBm |
| Output Voltage, High Power In | $\mathrm{P}_{\text {IN }}=-10 \mathrm{dBm}$ | 0.47 |  |  | V |
| Output Voltage, Low Power In | $\mathrm{PIN}_{\text {IN }}=-40 \mathrm{dBm}$ | 1.16 |  |  | V |


| Parameter | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{f}=5.8 \mathrm{GHz}$ | $\mathrm{R}_{\text {TADJ }}=500 \Omega$ |  |  |  |  |
| Input Impedance |  |  | 110\||0.05 |  | $\Omega \\| \mathrm{pF}$ |
| $\pm 1 \mathrm{~dB}$ Dynamic Range | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  | 50 |  | dB |
|  | $-40^{\circ} \mathrm{C}<\mathrm{T}_{\mathrm{A}}<+85^{\circ} \mathrm{C}$ |  | 48 |  | dB |
| Maximum Input Level | $\pm 1 \mathrm{~dB}$ error |  | -4 |  | dBm |
| Minimum Input Level | $\pm 1 \mathrm{~dB}$ error |  | -54 |  | dBm |
| Slope ${ }^{1}$ |  |  | -22 |  | $\mathrm{mV} / \mathrm{dB}$ |
| Intercept ${ }^{1}$ |  |  | 16 |  | dBm |
| Output Voltage, High Power In | $\mathrm{P}_{\text {IN }}=-10 \mathrm{dBm}$ |  | 0.59 |  | V |
| Output Voltage, Low Power In | $\mathrm{PIN}_{\text {I }}=-40 \mathrm{dBm}$ |  | 1.27 |  | V |
| $\mathrm{f}=8.0 \mathrm{GHz}$ | $\mathrm{R}_{\text {TADJ }}=$ open |  |  |  |  |
| Input Impedance |  |  | 28\||0.79 |  | $\Omega \\| \mathrm{pF}$ |
| $\pm 1 \mathrm{~dB}$ Dynamic Range | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  | 44 |  |  |
|  | $-40^{\circ} \mathrm{C}<\mathrm{T}_{\mathrm{A}}<+85^{\circ} \mathrm{C}$ |  | 35 |  | dB |
| Maximum Input Level | $\pm 1 \mathrm{~dB}$ error |  | -2 |  | dBm |
| Minimum Input Level | $\pm 1 \mathrm{~dB}$ error |  | -46 |  | dBm |
| Slope ${ }^{2}$ |  |  | -22 |  | $\mathrm{mV} / \mathrm{dB}$ |
| Intercept ${ }^{2}$ |  |  | 21 |  | dBm |
| Output Voltage, High Power In | $\mathrm{P}_{\text {IN }}=-10 \mathrm{dBm}$ |  | 0.70 |  | V |
| Output Voltage, Low Power In | $\mathrm{PIN}_{\text {I }}=-40 \mathrm{dBm}$ |  | 1.39 |  | V |
| OUTPUT INTERFACE | VOUT (Pin 5) |  |  |  |  |
| Voltage Swing | $\mathrm{V}_{\text {SET }}=0 \mathrm{~V}, \mathrm{RFIN}=$ open |  | VPos -0.1 |  | V |
|  | $\mathrm{V}_{\text {SET }}=1.7 \mathrm{~V}$, RFIN $=$ open |  | 10 |  | mV |
| Output Current Drive | $\mathrm{V}_{\text {SET }}=0 \mathrm{~V}, \mathrm{RFIN}=$ open |  | 10 |  | mA |
| Small Signal Bandwidth | RFIN $=-10 \mathrm{dBm}$, from CLPF to VOUT |  | 140 |  | MHz |
| Output Noise | $\begin{aligned} & \text { RFIN }=2.2 \mathrm{GHz},-10 \mathrm{dBm}, \mathrm{f}_{\text {NOISE }}=100 \mathrm{kHz}, \\ & \mathrm{C}_{\text {LPF }}=\text { open } \end{aligned}$ |  | 90 |  | $\mathrm{nV} / \sqrt{ } \mathrm{Hz}$ |
| Fall Time | $\begin{aligned} & \text { Input level }=\text { no signal to }-10 \mathrm{dBm}, 90 \% \text { to } 10 \% \text {, } \\ & C_{\text {LPF }}=8 \mathrm{pF} \end{aligned}$ |  | 18 |  | ns |
|  | Input level = no signal to $-10 \mathrm{dBm}, 90 \%$ to $10 \%$, $C_{\text {LPF }}=$ open, Rout $=150 \Omega$ |  | 6 |  | ns |
| Rise Time | Input level $=-10 \mathrm{dBm}$ to no signal, $10 \%$ to $90 \%$, $C_{\text {LpF }}=8 \mathrm{pF}$ |  | $20$ |  | ns |
|  | Input level $=-10 \mathrm{dBm}$ to no signal, $10 \%$ to $90 \%$, $C_{\text {LPF }}=$ open, Rout $=150 \Omega$ |  | 10 |  | ns |
| Video Bandwidth (or Envelope Bandwidth) |  |  | 50 |  | MHz |
| VSET INTERFACE | VSET (Pin 4) |  |  |  |  |
| Nominal Input Range | RFIN $=0 \mathrm{dBm}$, measurement mode |  | 0.35 |  | V |
|  | RFIN $=-50 \mathrm{dBm}$, measurement mode |  | 1.40 |  | V |
| Logarithmic Scale Factor |  |  | -45 |  | $\mathrm{dB} / \mathrm{V}$ |
| Input Resistance | RFIN $=-20 \mathrm{dBm}$, controller mode, $\mathrm{V}_{\text {SET }}=1 \mathrm{~V}$ |  |  |  |  |
| TADJ INTERFACE | TADJ (Pin 6) |  |  |  |  |
| Input Resistance | TADJ $=0.9 \mathrm{~V}$, sourcing $50 \mu \mathrm{~A}$ |  |  |  | k $\Omega$ |
| Disable Threshold Voltage | TADJ $=$ open |  | $V_{\text {POS }}-0.4$ |  | V |
| POWER INTERFACE | VPOS (Pin 7) |  |  |  |  |
| Supply Voltage |  | 3.0 |  | 5.5 | V |
| Quiescent Current |  | 18 | 22 | 30 | mA |
| vs. Temperature | $-40^{\circ} \mathrm{C} \leq \mathrm{T}_{\mathrm{A}} \leq+85^{\circ} \mathrm{C}$ |  | 60 |  | $\mu \mathrm{A} /{ }^{\circ} \mathrm{C}$ |
| Disable Current | TADJ $=\mathrm{V}_{\text {Pos }}$ |  | 200 |  |  |

[^0]
## AD8317

## ABSOLUTE MAXIMUM RATINGS

Table 2.

| Parameter | Rating |
| :--- | :--- |
| Supply Voltage, V ${ }_{\text {Pos }}$ | 5.7 V |
| V SET Voltage | 0 V to V Vos |
| Input Power (Single-Ended, Referenced | 12 dBm |
| to $50 \Omega$ ) |  |
| Internal Power Dissipation | 0.73 W |
| $\theta_{\text {JA }}$ | $55^{\circ} \mathrm{C} / \mathrm{W}$ |
| Maximum Junction Temperature | $125^{\circ} \mathrm{C}$ |
| Operating Temperature Range | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| Storage Temperature Range | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Lead Temperature (Soldering, 60 sec ) | $260^{\circ} \mathrm{C}$ |

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## ESD CAUTION

|  | ESD (electrostatic discharge) sensitive device. <br> Charged devices and circuit boards can discharge <br> without detection. Although this product features <br> patented or proprietary protection circuitry, damage <br> may occur on devices subjected to high energy ESD. <br> Therefore, proper ESD precautions should be taken to <br> avoid performance degradation or loss of functionality. |
| :--- | :--- |

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Table 3. Pin Function Descriptions

| Pin No. | Mnemonic | Description |
| :--- | :--- | :--- |
| 1 | INHI | RF Input. Nominal input range of -50 dBm to 0 dBm, referenced to $50 \Omega$; ac-coupled RF input. |
| 2 | COMM | Device Common. Connect to a low impedance ground plane. <br> Loop Filter Capacitor. In measurement mode, this capacitor sets the pulse response time and video bandwidth. |
| 3 | CLPF | In controller mode, the capacitance on this node sets the response time of the error amplifier/integrator. |
| 5 | VSET | Setpoint Control Input for Controller Mode or Feedback Input for Measurement Mode. <br> Measurement and Controller Output. In measurement mode, VOUT provides a decreasing linear-in-dB <br> representation of the RF input signal amplitude. In controller mode, VOUT is used to control the gain of a VGA or <br> VVA with a positive gain sense (increasing voltage increases gain). |
| 6 | TADJ | Temperature Compensation Adjustment. Frequency-dependent temperature compensation is set by connecting <br> a ground-referenced resistor to this pin. |
| 7 | VPOS | Positive Supply Voltage: 3.0 V to 5.5 V. <br> RF Common for INHI. AC-coupled RF common. <br> Exposed Pad. Exposed pad must be connected to ground via a low impedance path. |

## TYPICAL PERFORMANCE CHARACTERISTICS

$V_{\text {POS }}=3 \mathrm{~V} ; \mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C},-40^{\circ} \mathrm{C},+85^{\circ} \mathrm{C}$; CLPF $=1000 \mathrm{pF}$, unless otherwise noted. Black: $+25^{\circ} \mathrm{C}$; Blue: $-40^{\circ} \mathrm{C} ; \mathrm{Red}:+85^{\circ} \mathrm{C}$. Error is calculated by using the best-fit line between $\mathrm{P}_{\mathrm{IN}}=-40 \mathrm{dBm}$ and $\mathrm{P}_{\mathrm{IN}}=-10 \mathrm{dBm}$ at the specified input frequency, unless otherwise noted


Figure 3. Vout and Log Conformance vs. Input Amplitude at 900 MHz , $R_{\text {TADJ }}=18 \mathrm{k} \Omega$


Figure 4. Vout and Log Conformance vs. Input Amplitude at 1.9 GHz , $R_{\text {TADJ }}=8 \mathrm{k} \Omega$


Figure 5. Vout and Log Conformance vs. Input Amplitude at 2.2 GHz ,
$R_{\text {TADJ }}=8 \mathrm{k} \Omega$


Figure 6. Vout and Log Conformance vs. Input Amplitude at 3.6 GHz , $R_{T A D J}=8 \mathrm{k} \Omega$


Figure 7. Vout and Log Conformance vs. Input Amplitude at 5.8 GHz , $R_{\text {TADJ }}=500 \Omega$


Figure 8. Vout and Log Conformance vs. Input Amplitude at 8.0 GHz , $R_{T A D J}=$ Open, Error Calculated from $P_{I N}=-34 \mathrm{dBm}$ to $P_{I N}=-16 \mathrm{dBm}$


Figure 9. Vout and Log Conformance vs. Input Amplitude at 900 MHz , Multiple Devices, $R_{T A D J}=18 \mathrm{k} \Omega$


Figure 10. Vout and Log Conformance vs. Input Amplitude at 1.9 GHz, Multiple Devices, $R_{T A D J}=8 \mathrm{k} \Omega$


Figure 11. Vout and Log Conformance vs. Input Amplitude at 2.2 GHz , Multiple Devices, $R_{\text {TADJ }}=8 \mathrm{k} \Omega$


Figure 12. Vout and Log Conformance vs. Input Amplitude at 3.6 GHz, Multiple Devices, $R_{T A D J}=8 \mathrm{k} \Omega$


Figure 13. Vout and Log Conformance vs. Input Amplitude at 5.8 GHz , Multiple Devices, $R_{T A D J}=500 \Omega$


Figure 14. Vout and Log Conformance vs. Input Amplitude at 8.0 GHz , Multiple Devices, $R_{T A D J}=$ Open,
Error Calculated from $P_{I N}=-34 \mathrm{dBm}$ to $P_{I N}=-16 \mathrm{dBm}$


Figure 15. Input Impedance vs. Frequency; No Termination Resistor on INHI (Impedance De-Embedded to Input Pins), $Z_{0}=50 \Omega$


Figure 16. Power-On/Power-Off Response Time; VPOS $=3.0 \mathrm{~V}$; Input AC-Coupling Capacitors $=10 \mathrm{pF} ; C_{L P F}=$ Open


Figure 17. Vout Pulse Response Time; Pulsed RF Input $0.1 \mathrm{GHz},-10 \mathrm{dBm}$; $C_{\text {LPF }}=$ Open; $R_{\text {LOAD }}=150 \Omega$


Figure 18. Noise Spectral Density of Output; $C_{L P F}=$ Open


Figure 19. Noise Spectral Density of Output Buffer (from CLPF to VOUT); $C_{\text {LPF }}=0.1 \mu \mathrm{~F}$


Figure 20. Output Voltage Stability vs. Supply Voltage at 1.9 GHz
When Vpos Varies by 10\%

## THEORY OF OPERATION

The AD8317 is a 6-stage demodulating logarithmic amplifier, specifically designed for use in RF measurement and power control applications at frequencies up to 10 GHz . A block diagram is shown in Figure 21. Sharing much of its design with the AD8318 logarithmic detector/controller, the AD8317 maintains tight intercept variability vs. temperature over a 50 dB range. Additional enhancements over the AD8318, such as a reduced RF burst response time of 6 ns to $10 \mathrm{~ns}, 22 \mathrm{~mA}$ supply current, and board space requirements of only $2 \mathrm{~mm} \times 3 \mathrm{~mm}$, add to the low cost and high performance benefits of the AD8317.


Figure 21. Block Diagram
A fully differential design, using a proprietary, high speed SiGe process, extends high frequency performance. Input INHI receives the signal with a low frequency impedance of nominally $500 \Omega$ in parallel with 0.7 pF . The maximum input with $\pm 1 \mathrm{~dB} \log -$ conformance error is typically 0 dBm (referenced to $50 \Omega$ ). The noise spectral density referred to the input is $1.15 \mathrm{nV} / \sqrt{ } \mathrm{Hz}$, which is equivalent to a voltage of $118 \mu \mathrm{~V} \mathrm{rms}$ in a 10.5 GHz bandwidth or a noise power of -66 dBm (referenced to $50 \Omega$ ). This noise spectral density sets the lower limit of the dynamic range. However, the low end accuracy of the AD8317 is enhanced by specially shaping the demodulating transfer
characteristic to partially compensate for errors due to internal noise. The common pin, COMM, provides a quality low impedance connection to the printed circuit board (PCB) ground. The package paddle, which is internally connected to the COMM pin, must also be grounded to the PCB to reduce thermal impedance from the die to the PCB.
The logarithmic function is approximated in a piecewise fashion by six cascaded gain stages. (For a more comprehensive explanation of the logarithm approximation, see the AD8307 data sheet.) The cells have a nominal voltage gain of 9 dB each and a 3 dB bandwidth of 10.5 GHz . Using precision biasing, the gain is stabilized over temperature and supply variations. The overall dc gain is high, due to the cascaded nature of the gain stages. An offset compensation loop is included to correct for offsets within the cascaded cells. At the output of each of the gain stages, a square-law detector cell is used to rectify the signal.
The RF signal voltages are converted to a fluctuating differential current having an average value that increases with signal level. Along with the six gain stages and detector cells, an additional detector is included at the input of the AD8317, providing a 50 dB dynamic range in total. After the detector currents are summed and filtered, the following function is formed at the summing node:

$$
\begin{equation*}
I_{D} \times \log _{10}\left(V_{\text {IN }} / V_{\text {INTERCEPT }}\right) \tag{1}
\end{equation*}
$$

where:
$I_{D}$ is the internally set detector current.
$V_{I N}$ is the input signal voltage.
$V_{\text {INTERCEPT }}$ is the intercept voltage (that is, when $\mathrm{V}_{\text {IN }}=\mathrm{V}_{\text {INTERCEPT }}$, the output voltage would be 0 V , if it were capable of going to 0 V ).

## USING THE AD8317

## BASIC CONNECTIONS

The AD8317 is specified for operation up to 10 GHz ; as a result, low impedance supply pins with adequate isolation between functions are essential. A power supply voltage of between 3.0 V and 5.5 V must be applied to VPOS. Power supply decoupling capacitors of 100 pF and $0.1 \mu \mathrm{~F}$ must be connected close to this power supply pin.

${ }^{1}$ SEE THE TEMPERATURE COMPENSATION OF OUTPUT VOLTAGE SECTION. ${ }^{2}$ SEE THE OUTPUT FILTERING SECTION.

Figure 22. Basic Connections
The paddle of the LFCSP package is internally connected to COMM. For optimum thermal and electrical performance, the paddle must be soldered to a low impedance ground plane.

## INPUT SIGNAL COUPLING

The RF input (INHI) is single-ended and must be ac-coupled. The INLO (input common) must be ac-coupled to ground. Suggested coupling capacitors are 47 nF ceramic 0402 -style capacitors for input frequencies of 1 MHz to 10 GHz . The coupling capacitors must be mounted close to the INHI and INLO pins. The coupling capacitor values can be increased to lower the high-pass cutoff frequency of the input stage. The high-pass corner is set by the input coupling capacitors and the internal 10 pF high-pass capacitor. The dc voltage on INHI and INLO is approximately one diode voltage drop below Vpos.


Figure 23. Input Interface
While the input can be reactively matched, in general, this is not necessary. An external $52.3 \Omega$ shunt resistor (connected on the signal side of the input coupling capacitors, as shown in

Figure 22) combines with the relatively high input impedance to give an adequate broadband $50 \Omega$ match.
The coupling time constant, $50 \times \mathrm{C}_{\mathrm{C}} / 2$, forms a high-pass corner with a 3 dB attenuation at $\mathrm{f}_{\mathrm{HP}}=1 /\left(2 \pi \times 50 \times \mathrm{C}_{\mathrm{C}}\right)$, where $\mathrm{C} 1=\mathrm{C} 2=\mathrm{C}$. Using the typical value of 47 nF , this high-pass corner is $\sim 68 \mathrm{kHz}$. In high frequency applications, $\mathrm{f}_{\mathrm{HP}}$ must be as large as possible to minimize the coupling of unwanted low frequency signals. In low frequency applications, add a simple RC network forming a low-pass filter at the input for similar reasons. This low-pass filter network must generally be placed at the generator side of the coupling capacitors, thereby lowering the required capacitance value for a given high-pass corner frequency.

## OUTPUT INTERFACE

The VOUT pin is driven by a PNP output stage. An internal $10 \Omega$ resistor is placed in series with the output and the VOUT pin. The rise time of the output is limited mainly by the slew on CLPF. The fall time is an RC-limited slew given by the load capacitance and the pull-down resistance at VOUT. There is an internal pull-down resistor of $1.6 \mathrm{k} \Omega$. A resistive load at VOUT is placed in parallel with the internal pull-down resistor to provide additional discharge current.


Figure 24. Output Interface
To reduce the fall time, load VOUT with a resistive load of $<1.6 \mathrm{k} \Omega$. For example, with an external load of $150 \Omega$, the AD8317 fall time is $<7 \mathrm{~ns}$.

## SETPOINT INTERFACE

The $V_{\text {SET }}$ input drives the high impedance ( $40 \mathrm{k} \Omega$ ) input of an internal op amp. The $\mathrm{V}_{\text {SET }}$ voltage appears across the internal $1.5 \mathrm{k} \Omega$ resistor to generate $\mathrm{I}_{\text {SET }}$. When a portion of $\mathrm{V}_{\text {OUT }}$ is applied to VSET, the feedback loop forces

$$
\begin{equation*}
-I_{D} \times \log _{10}\left(V_{I N} / V_{\text {INTERCEPT }}\right)=I_{S E T} \tag{2}
\end{equation*}
$$

If $\mathrm{V}_{\text {SET }}=\mathrm{V}_{\text {out }} / 2 \mathrm{x}$, then $\mathrm{I}_{\text {SET }}=\mathrm{V}_{\text {out }} /(2 \mathrm{x} \times 1.5 \mathrm{k} \Omega)$.
The result is


Figure 25. VSET Interface

## AD8317

The slope is given by

$$
-I_{D} \times 2 x \times 1.5 \mathrm{k} \Omega=-22 \mathrm{mV} / \mathrm{dB} \times x
$$

For example, if a resistor divider to ground is used to generate a $\mathrm{V}_{\text {SET }}$ voltage of $\mathrm{V}_{\text {out }} / 2, \mathrm{x}=2$. The slope is set to $-880 \mathrm{~V} /$ decade or $-44 \mathrm{mV} / \mathrm{dB}$.

## TEMPERATURE COMPENSATION OF OUTPUT VOLTAGE

The primary component of the variation in Vout vs. temperature, as the input signal amplitude is held constant, is the drift of the intercept. This drift is also a weak function of the input signal frequency; therefore, provision is made for the optimization of internal temperature compensation at a given frequency by providing Pin TADJ.


Figure 26. TADJ Interface
$\mathrm{R}_{\text {TAD }}$ is connected between TADJ and ground. The value of this resistor partially determines the magnitude of an analog correction coefficient, which is used to reduce intercept drift.
The relationship between output temperature drift and frequency is not linear and cannot be easily modeled. As a result, experimentation is required to choose the correct TADJ resistor. Table 4 shows the recommended values for some commonly used frequencies.

Table 4. Recommended $\mathrm{R}_{\text {tadj }}$ Values

| Frequency | Recommended RTADJ |
| :--- | :--- |
| 50 MHz | $18 \mathrm{k} \Omega$ |
| 100 MHz | $18 \mathrm{k} \Omega$ |
| 900 MHz | $18 \mathrm{k} \Omega$ |
| 1.8 GHz | $8 \mathrm{k} \Omega$ |
| 1.9 GHz | $8 \mathrm{k} \Omega$ |
| 2.2 GHz | $8 \mathrm{k} \Omega$ |
| 3.6 GHz | $8 \mathrm{k} \Omega$ |
| 5.3 GHZ | $500 \Omega$ |
| 5.8 GHz | $500 \Omega$ |
| 8 GHz | Open |

## MEASUREMENT MODE

When the Vout voltage or a portion of the Vout voltage is fed back to the VSET pin, the device operates in measurement mode. As seen in Figure 27, the AD8317 has an offset voltage, a negative slope, and a Vout measurement intercept at the high end of its input signal range.


The output voltage vs. input signal voltage of the AD8317 is linear-in- dB over a multidecade range. The equation for this function is

$$
\begin{align*}
& V_{\text {OUT }}=X \times V_{\text {SLOPE/DEC }} \times \log _{10}\left(V_{\text {IN }} / V_{\text {INTERCEPT }}\right)  \tag{3}\\
& =X \times V_{\text {SLOPE/AB }} \times 20 \times \log _{10}\left(V_{I N} / V_{\text {INTERCEPT }}\right) \tag{4}
\end{align*}
$$

where:
$X$ is the feedback factor in $\mathrm{V}_{\text {set }}=\mathrm{V}_{\text {out }} / \mathrm{X}$.
$V_{\text {SLOPE/DEC }}$ is nominally $-440 \mathrm{mV} /$ decade, or $-22 \mathrm{mV} / \mathrm{dB}$.
$V_{\text {INTERCEPT }}$ is the x -axis intercept of the linear-in- dB portion of the Vout vs. $\mathrm{P}_{\text {IN }}$ curve (see Figure 27).
$V_{\text {INTERCEPT }}$ is 2 dBV for a sinusoidal input signal.
An offset voltage, $V_{\text {Offset, }}$ of 0.35 V is internally added to the detector signal, so that the minimum value for Vout is $\mathrm{X} \times$ Voffset; therefore, for $\mathrm{X}=1$, the minimum Vout is 0.35 V .
The slope is very stable vs. process and temperature variation. When base-10 logarithms are used, $\mathrm{V}_{\text {slope/decade }}$ represents the volts/decade. A decade corresponds to 20 dB ; $\mathrm{V}_{\text {sLope/Decade }} / 20=$ $\mathrm{V}_{\text {sLope/dB }}$ represents the slope in volts/dB.

As noted in Equation 3 and Equation 4, the VOUT voltage has a negative slope. This is also the correct slope polarity to control the gain of many power amplifiers in a negative feedback configuration. Because both the slope and intercept vary slightly with frequency, it is recommended to refer to the Specifications section for application-specific values for slope and intercept.
Although demodulating log amps respond to input signal voltage, not input signal power, it is customary to discuss the amplitude of high frequency signals in terms of power. In this case, the characteristic impedance of the system, $\mathrm{Z}_{0}$, must be known to convert voltages to their corresponding power levels. The following equations are used to perform this conversion:

$$
\begin{align*}
& P[\mathrm{dBm}]=10 \times \log _{10}\left(V_{\text {RMS }}{ }^{2} /\left(Z_{0} \times 1 \mathrm{~mW}\right)\right)  \tag{5}\\
& P[\mathrm{dBV}]=20 \times \log _{10}\left(V_{\text {RMS }} / 1 \mathrm{~V}_{\mathrm{RMS}}\right)  \tag{6}\\
& P[\mathrm{dBm}]=P[\mathrm{dBV}]-10 \times \log _{10}\left(Z_{0} \times 1 \mathrm{~mW} / 1 \mathrm{~V}_{\text {RMS }}\right) \tag{7}
\end{align*}
$$

For example, $\mathrm{P}_{\text {Intercept }}$ for a sinusoidal input signal expressed in terms of dBm (decibels referred to 1 mW ), in a $50 \Omega$ system is

$$
\begin{align*}
& P_{\text {INTERCEPT }}[\mathrm{dBm}]= \\
& P_{\text {INTERCEPT }}[\mathrm{dBV}]-10 \times \log _{10}\left(Z_{0} \times 1 \mathrm{~mW} / 1 \mathrm{~V}_{\text {RMS }^{2}}\right)= \\
& 2 \mathrm{dBV}-10 \times \log _{10}\left(50 \times 10^{-3}\right)=15 \mathrm{dBm} \tag{8}
\end{align*}
$$

For a square wave input signal in a $200 \Omega$ system,
$P_{\text {INTERCEPT }}=$
$-1 \mathrm{dBV}-10 \times \log _{10}\left[\left(200 \Omega \times 1 \mathrm{~mW} / 1 \mathrm{~V}_{\text {RMs }}{ }^{2}\right)\right]=6 \mathrm{dBm}$
Further information on the intercept variation dependence upon waveform can be found in the AD8313 and AD8307 data sheets.

## SETTING THE OUTPUT SLOPE IN MEASUREMENT MODE

To operate in measurement mode, VOUT must be connected to VSET. Connecting VOUT directly to VSET yields the nominal logarithmic slope of approximately $-22 \mathrm{mV} / \mathrm{dB}$. The output swing corresponding to the specified input range is then approximately 0.35 V to 1.7 V . The slope and output swing can be increased by placing a resistor divider between VOUT and VSET (that is, one resistor from VOUT to VSET and one resistor from VSET to ground). The input impedance of VSET is approximately $40 \mathrm{k} \Omega$. To prevent this input impedance from affecting the resulting slope, keep slope-setting resistors below $20 \mathrm{k} \Omega$. If two equal resistors are used (for example, $10 \mathrm{k} \Omega / 10 \mathrm{k} \Omega$ ), the slope doubles to approximately $-44 \mathrm{mV} / \mathrm{dB}$.


Figure 28. Increasing the Slope

## CONTROLLER MODE

The AD8317 provides a controller mode feature at the VOUT pin. By using $\mathrm{V}_{\text {set }}$ for the setpoint voltage, it is possible for the AD8317 to control subsystems, such as power amplifiers (PAs), variable gain amplifiers (VGAs), or variable voltage attenuators (VVAs), that have output power that increases monotonically with respect to their gain control signal.
To operate in controller mode, the link between VSET and VOUT is broken. A setpoint voltage is applied to the VSET input, VOUT is connected to the gain control terminal of the VGA, and the RF input of the detector is connected to the output of the VGA (usually using a directional coupler and some additional attenuation). Based on the defined relationship
between Vout and the RF input signal when the device is in measurement mode, the AD8317 adjusts the voltage on VOUT (VOUT is now an error amplifier output) until the level at the RF input corresponds to the applied $\mathrm{V}_{\text {SET }}$. When the AD8317 operates in controller mode, there is no defined relationship between the $V_{\text {SET }}$ and the Vout voltage; Vout settles to a value that results in the correct input signal level appearing at INHI/INLO.

For this output power control loop to be stable, a groundreferenced capacitor must be connected to the CLPF pin. This capacitor, $\mathrm{C}_{\text {FLT }}$, integrates the error signal (in the form of a current) to set the loop bandwidth and ensure loop stability. Further details on control loop dynamics can be found in the AD8315 data sheet.


Decreasing $\mathrm{V}_{\text {SET }}$, which corresponds to demanding a higher signal from the VGA, increases Vout. The gain control voltage of the VGA must have a positive sense. A positive control voltage to the VGA increases the gain of the device.
The basic connections for operating the AD8317 in an automatic gain control (AGC) loop with the ADL5330 are shown in Figure 30. The ADL5330 is a 10 MHz to 3 GHz VGA. It offers a large gain control range of 60 dB with $\pm 0.5 \mathrm{~dB}$ gain stability. This configuration is similar to Figure 29.
The gain of the ADL5330 is controlled by the output pin of the AD8317. This voltage, Vout, has a range of 0 V to near $\mathrm{V}_{\text {pos. }}$. To avoid overdrive recovery issues, the AD8317 output voltage can be scaled down using a resistive divider to interface with the 0 V to 1.4 V gain control range of the ADL5330.

A coupler/attenuation of 21 dB is used to match the desired maximum output power from the VGA to the top end of the linear operating range of the AD8317 (approximately -5 dBm at 900 MHz ).


Figure 30. AD8317 Operating in Controller Mode to Provide Automatic Gain Control Functionality in Combination with the ADL5330

Figure 31 shows the transfer function of the output power vs. the setpoint voltage over temperature for a 900 MHz sine wave with an input power of -1.5 dBm . Note that the power control of the AD8317 has a negative sense. Decreasing $\mathrm{V}_{\text {SET }}$, which corresponds to demanding a higher signal from the ADL5330, increases gain.
The AGC loop is capable of controlling signals just under the full 60 dB gain control range of the ADL5330. The performance over temperature is most accurate over the highest power range, where it is generally most critical. Across the top 40 dB range of output power, the linear conformance error is well within $\pm 0.5 \mathrm{~dB}$ over temperature.


Figure 31. ADL5330 Output Power vs. AD8317 Setpoint Voltage, $P_{I_{N}}=-1.5 \mathrm{dBm}$

For the AGC loop to remain in equilibrium, the AD8317 must track the envelope of the ADL5330 output signal and provide the necessary voltage levels to the ADL5330 gain control input. Figure 32 shows an oscilloscope screenshot of the AGC loop depicted in Figure 30. A 100 MHz sine wave with $50 \%$ AM modulation is applied to the ADL5330. The output signal from the VGA is a constant envelope sine wave with amplitude corresponding to a setpoint voltage at the AD8317 of 1.5 V . Also shown is the gain control response of the AD8317 to the changing input envelope.


Figure 32. Oscilloscope Screenshot Showing an AM Modulated Input Signal and the Response from the AD8317

Figure 33 shows the response of the AGC RF output to a pulse on VSET. As $\mathrm{V}_{\text {SET }}$ decreases from 1.7 V to 0.4 V , the AGC loop responds with an RF burst. In this configuration, the input signal to the ADL5330 is a 1 GHz sine wave at a power level of -15 dBm .


Figure 33. Oscilloscope Screenshot Showing the Response Time of the AGC Loop
Response time and the amount of signal integration are controlled by $\mathrm{C}_{\text {FLT. }}$. This functionality is analogous to the feedback capacitor around an integrating amplifier. Although it is possible to use large capacitors for $\mathrm{C}_{\text {FLT }}$, in most applications, values under 1 nF provide sufficient filtering.

Calibration in controller mode is similar to the method used in measurement mode. A simple 2-point calibration can be done by applying two known $\mathrm{V}_{\text {set }}$ voltages or DAC codes and measuring the output power from the VGA. Slope and intercept can then be calculated by:

$$
\begin{align*}
& \text { Slope }=\left(V_{\text {SET1 }}-V_{\text {SET2 }}\right) /\left(\text { Pout1 }-P_{\text {out } 2}\right)  \tag{9}\\
& \text { Intercept }=\text { Pout1 }-V_{\text {SET1 }} / \text { Slope }  \tag{10}\\
& V_{\text {SETx }}=\text { Slope } \times\left(P_{\text {outx }}-\text { Intercept }\right) \tag{11}
\end{align*}
$$

More information on the use of the ADL5330 in AGC applications can be found in the ADL5330 data sheet.

## OUTPUT FILTERING

For applications in which maximum video bandwidth and, consequently, fast rise time are desired, it is essential that the CLPF pin be left unconnected and free of any stray capacitance.

The nominal output video bandwidth of 50 MHz can be reduced by connecting a ground-referenced capacitor ( $\mathrm{C}_{\text {FLt }}$ ) to the CLPF pin, as shown in Figure 34. This is generally done to reduce output ripple (at twice the input frequency for a symmetric input waveform such as sinusoidal signals).


Figure 34. Lowering the Postdemodulation Bandwidth
Cflt is selected by

$$
\begin{equation*}
C_{F L T}=\frac{1}{(2 \pi \times 1.5 \mathrm{k} \Omega \times \text { Video Bandwidth })}-3.5 \mathrm{pF} \tag{12}
\end{equation*}
$$

The video bandwidth must typically be set to a frequency equal to about one-tenth the minimum input frequency. This ensures that the output ripple of the demodulated log output, which is at twice the input frequency, is well filtered.
In many log amp applications, it may be necessary to lower the corner frequency of the postdemodulation filter to achieve low output ripple while maintaining a rapid response time to changes in signal level. An example of a 4-pole active filter is shown in the AD8307 data sheet.

## OPERATION BEYOND 8 GHz

The AD8317 is specified for operation up to 8 GHz , but it provides useful measurement accuracy over a reduced dynamic range of up to 10 GHz . Figure 35 shows the performance of the AD8317 over temperature at 10 GHz when the device is configured as shown in Figure 22. Dynamic range is reduced at this frequency, but the AD8317 does provide 30 dB of measurement range within $\pm 3 \mathrm{~dB}$ of linearity error.


Figure 35. Vout and Log Conformance vs. Input Amplitude at 10.0 GHz , Multiple Devices, $R_{\text {TADJ }}=$ Open, $C_{L P F}=1000 \mathrm{pF}$
Implementing an impedance match for frequencies beyond 8 GHz can improve the sensitivity of the AD8317 and measurement range.

Operation beyond 10 GHz is possible, but part-to-part variation, most notably in the intercept, becomes significant.

## EVALUATION BOARD

Table 5. Evaluation Board (Rev. A) Configuration Options

| Component | Function | Default Conditions |
| :---: | :---: | :---: |
| VPOS, GND | Supply and Ground Connections. | Not applicable |
| R1, C1, C2 | Input Interface. <br> The $52.3 \Omega$ resistor in Position R1 combines with the internal input impedance of the AD8317 to give a broadband input impedance of about $50 \Omega$. C 1 and C2 are dc-blocking capacitors. A reactive impedance match can be implemented by replacing R1 with an inductor and C1 and C2 with appropriately valued capacitors. | $\begin{aligned} & \mathrm{R} 1=52.3 \Omega(\text { Size 0402 }) \\ & \mathrm{C} 1=47 \mathrm{nF}(\text { Size 0402) } \\ & \mathrm{C} 2=47 \mathrm{nF} \text { (Size 0402) } \end{aligned}$ |
| R5, R7 | Temperature Compensation Interface. <br> The internal temperature compensation network is optimized for input signals up to 3.6 GHz when R 7 is $10 \mathrm{k} \Omega$. This circuit can be adjusted to optimize performance for other input frequencies by changing the value of the resistor in Position R7. See Table 4 for specific $\mathrm{R}_{\text {TADJ }}$ resistor values. | $\begin{aligned} & \text { R5 }=200 \Omega(\text { Size 0402 }) \\ & \text { R7 }=\text { open }(\text { Size 0402 }) \end{aligned}$ |
| R2, R3, R4, R6, RL, CL | Output Interface-Measurement Mode. <br> In measurement mode, a portion of the output voltage is fed back to the VSET pin via R2. The magnitude of the slope of the VOUT output voltage response can be increased by reducing the portion of Vout that is fed back to VSET. R6 can be used as a back-terminating resistor or as part of a single-pole, low-pass filter. | $\begin{aligned} & \mathrm{R} 2=0 \Omega(\text { Size 0402) } \\ & \text { R3 }=\mathrm{open}(\text { Size 0402) } \\ & \text { R4 }=\mathrm{open}(\text { Size 0402) } \\ & \text { R6 }=1 \mathrm{k} \Omega(\text { Size 0402) } \\ & \text { RL }=\mathrm{CL}=\text { open }(\text { Size 0402 }) \end{aligned}$ |
| R2, R3 | Output Interface-Controller Mode. <br> In this mode, R2 must be open. In controller mode, the AD8317 can control the gain of an external component. A setpoint voltage is applied to Pin VSET, the value of which corresponds to the desired RF input signal level applied to the AD8317 RF input. A sample of the RF output signal from this variable gain component is selected, typically via a directional coupler, and applied to the AD8317 RF input. The voltage at the VOUT pin is applied to the gain control of the variable gain element. A control voltage is applied to the VSET pin. The magnitude of the control voltage can optionally be attenuated via the voltage divider comprising R2 and R3, or a capacitor can be installed in Position R3 to form a low-pass filter along with R2. | $\begin{aligned} & \text { R2 }=\text { open }(\text { Size 0402 }) \\ & \text { R3 }=\text { open }(\text { Size 0402 }) \end{aligned}$ |
| C4, C5 | Power Supply Decoupling. <br> The nominal supply decoupling consists of a 100 pF filter capacitor placed physically close to the AD8317 and a $0.1 \mu \mathrm{~F}$ capacitor placed nearer to the power supply input pin. | $\begin{aligned} & C 4=0.1 \mu F(\text { Size 0603 }) \\ & C 5=100 \mathrm{pF}(\text { Size 0402 }) \end{aligned}$ |
| C3 | Filter Capacitor. <br> The low-pass corner frequency of the circuit that drives the VOUT pin can be lowered by placing a capacitor between CLPF and ground. Increasing this capacitor increases the overall rise/fall time of the AD8317 for pulsed input signals. See the Output Filtering section for more details. | C3 $=8.2 \mathrm{pF}$ (Size 0402) |



Figure 36. Evaluation Board Schematic
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Figure 37. Component Side Layout


Figure 38. Component Side Silkscreen

## DIE INFORMATION



BOND PAD STATISTICS
ALL MEASURMENTS IN MICRONS.
MINIMUM PASSIVATION OPENING: $59 \times 59$ MIN PAD PITCH: 89
die size calculation
ALL MEASURMENTS IN MICRONS.
DIEX (WIDTH OF DIE IN X DIRECTION) $=670$
DIEY (WIDTH OF DIE IN Y DIRECTION) = 1325
DIE THICKNESS $=305$ MICRONS
BALL BOND SHEAR STRENGTH SPECIFICATION: MINIMUM 15 GRAMS
Figure 39. Die Outline Dimensions

Table 6. Die Pad Function Descriptions

| Pad No. | X Coordinate ${ }^{\mathbf{1}}$ | Y Coordinate ${ }^{\mathbf{2}}$ | Mnemonic | Description |
| :--- | :--- | :--- | :--- | :--- |
| 1 | -158 | +538 | INHI | RF Input. Nominal input range of -50 dBm to 0 dBm, referenced to $50 \Omega ;$ <br> ac-coupled RF input. |
| 2,2 | $-213,-213$ | $+436,+347$ | COMM <br> Cevice Common. Connect both pads to a low impedance ground plane. <br> 3 | -209 |

[^1]
## OUTLINE DIMENSIONS



Figure 40. 8-Lead Lead Frame Chip Scale Package [LFCSP]
$2 \mathrm{~mm} \times 3 \mathrm{~mm}$ Body and 0.75 mm Package Height
(CP-8-23)
Dimensions shown in millimeters
ORDERING GUIDE

| Model $^{1}$ | Temperature Range | Package Description | Package Option | Marking Code |
| :--- | :--- | :--- | :--- | :--- |
| AD8317ACPZ-R7 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 -Lead LFCSP, $7^{\prime \prime}$ Tape and Reel | CP-8-23 | Q1 |
| AD8317ACPZ-R2 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 -Lead LFCSP, 7 "Tape and Reel | CP-8-23 | Q1 |
| AD8317ACPZ-WP | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8-Lead LFCSP, Waffle Pack | CP-8-23 | Q1 |
| AD8317ACHIPS | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | Die |  |  |
| AD8317-EVALZ |  | Evaluation Board |  |  |

[^2]
## X-ON Electronics

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[^0]:    ${ }^{1}$ Slope and intercept are determined by calculating the best-fit line between the power levels of -40 dBm and -10 dBm at the specified input frequency.
    ${ }^{2}$ Slope and intercept are determined by calculating the best-fit line between the power levels of -34 dBm and -16 dBm at 8.0 GHz .

[^1]:    ${ }^{1}$ Die $X($ width of die in $X$ direction $)=670$.
    ${ }^{2}$ Die $Y($ width of die in $Y$ direction $)=1325$.

[^2]:    ${ }^{1} Z=$ RoHS Compliant Part.

